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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Kenzi NISIKAWA

Group Art Unit : Not Yet Assigned

Appl. No. : 10/553,909

(U.S. National Stage of PCT/JP2004005758)

Filed : April 22, 2004

Examiner : Not Yet Assigned

For : OPTICAL CHARACTERISTIC MEASURING INSTRUMENT AND
METHOD, PROGRAM, AND RECORD MEDIUM ON WHICH THE
PROGRAM IS RECORDED

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop AMENDMENT
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir :

In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and §§1.97-1.98, Applicant hereby brings the following information to the attention of the Examiner in charge of the above-identified application, which includes information cited and discussed in the specification and the International Search Report issued in connection with International Patent Application No. PCT/JP2004/005758, of which the present application is the U.S. National Stage Application. A copy of the International Search Report was enclosed with the papers when entering the U.S. National Stage on October 21, 2005. The Examiner is requested to review these materials to inspect the relevance indicated during international examination with respect to the documents cited

therein. The following is a list of the documents cited in the above-noted documents:

Japanese Laid-open Patent Publication No. HEI 9-264814, together with an English language Abstract of the same and patent family member U.S. Patent No. 5,717,489. Applicant notes that the Japanese document is cited on page 1 of the specification of the above-captioned application;

Japanese Laid-open Patent Publication No. 2003-106942, together with an English language Abstract and machine translation of the same; and

Japanese Laid-open Patent Publication No. 2002-368702, together with an English language Abstract of the same and patent family member U.S. Patent Application Publication No. 2002/0149823.

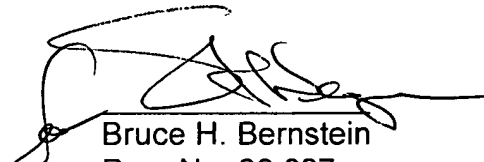
Further to 37 C.F.R. §1.98 (a)(2)(ii), copies of the U.S. patent and the U.S. patent application publication are not enclosed herewith. However, if copies are needed, the Examiner is respectfully requested to contact the undersigned.

Applicant respectfully requests that the Examiner consider the above material and cite the same. Copies of the above-noted foreign documents are attached hereto and all of the above-noted documents are listed on the attached PTO-1449 Form. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of the completed Form to Applicant with the next official communication in the present application.

Applicant notes that an Office Action on the merits has not issued in the present application, and thus, no fee is believed necessary to ensure consideration of the submitted material.

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully Submitted,
Kenzi NISIKAWA



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10/553,909

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[illegible]

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	9	- 2 6 4 8 1 4	10/07/97	JAPAN			
	2003	- 1 0 6 9 4 2	04/09/03	JAPAN			X
	2002	- 3 6 8 7 0 2	12/20/02	JAPAN			

	1	English Language Abstract of JP 9-264814.
	2	English Language Abstract of JP 2003-106942.
	3	English Language Abstract of JP 2002-368702.

DATE CONSIDERED

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.